Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/734,834	TANAKA ET AL.	
Examiner	Art Unit	
 Kiesha L. Rose	2822	

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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Interferno	Interfernce search		KLR		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated search	12/8/2006	KLR
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